

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Multiple sheets used when necessary)

SHEET 1 OF 2

Application No.	10/506,362
Filing Date	May 11, 2005
First Named Inventor	Weh et al.
Art Unit	2822
Examiner	Price, Craig James
Attorney Docket No.	JFIE5.002APC

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	US 2,070,013	02-09-1937	Krannak, Steven J.	
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Examiner Signature

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	31	US 6,394,150 B1	05-28-2002	Haimovich et al.	
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